

SAMXON BRAND ALUMINUM ELECTROLYTIC CAPACITORS PRODUCT SPECIFICATION 規格書

CUSTOMER :

(客戶): 志盛翔

DATE: (日期):2021-09-30

| CATEGORY (品名) | : | ALUM | IINUM ELECTROLYTIC CAPACITORS |
|------------------|---|------|-------------------------------|
| DESCRIPTION (型号) | : | GF 6 | 53V330µF(q10x20) |
| VERSION (版本) | : | 01 | |
| Customer P/N | : | | |
| SUPPLIER | : | | |
| | | | |

| SUPPL | IER |] [| CUSTOMER | | | | |
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| PREPARED (拟定) | CHECKED (审核) | | APPROVAL (批准) | SIGNATURE (签名) | | | |
| 邓文文 | 付婷婷 | | | | | | |

ELECTROLYTIC CAPACITOR SPECIFICATION GF SERIES

| | SPECIFICATION GF SERIES | | | | | | ALTERNATION HISTORY RECORDS | | | |
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| Rev. | Date | Mark | | age | Contents | Purpose | Drafter | Approver | | |
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| | MAN YUE ELECTRO COMPANY LIMIT | | | CA SPEC | CTROLYTIC PACITOR CIFICATION F SERIES | | | S | | ON | |
|----------|----------------------------------|-----------|-------------------------------|--------------------|--|----------------------------|--|---------------------------|-------------------|------------------------|--------|
| Гał | ble 1 Product Dimens | ions an | d Characterist | ics | | i | | | | | |
| | ■ 1.4 | +2.0/-2.0 | | | | | | | | Unit: mm | |
| | | | | ÷. | | Shape Code | | D L | 10 20 | | |
| | D+0.5 | | | F±0.5 | | СВ | | F H d | 5.0 3.5 0.6 | | |
| | I | | | | | | | | | | |
| abl | le 1: | | H±0.5 - | | tan ō Lookoor | Max Ripple | Impedance | | Dim | ension | |
| abl N | SAMXON | | Cap. (µF) Cap tolerance | Temp. range(°C) | tan δ Leakage (120Hz, Current 20℃) (μA,2mir | Current at 105 C 100kHz | Impedance at 20°C 100kHz (Ωmax) | Load lifetime (Hrs) | | ension (mm) F фd | Sleeve |

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SAMXON

1. Application

This specification applies to polar Aluminum electrolytic capacitor (foil type) used in electronic equipment. Designed capacitor's quality meets IEC60384.

2. Part Number System

| EGS | | 105 | | N | 1 H | | D 1 | 1 | ТС | | SA I | 2 |
|---------------|----------|----------|------------|--------------------|------------------|------------|---------------------|----------------|-------------|----------|---------------------------------------|------------------|
| SERIES | CAP | PACITAN | CE TOLE | RANCE | VOLTA | GE | CASE | SIZE | TYPE | | MXON SLE UCT LINE MAT | EVE |
| | | | | | | | | | | TROD | | - NIPAL |
| Serles EKF | Cap (uF) | Code | Tol. (%) | Code | Vol. (W.V.) 2 | Code 0D | Case Diameter(Φ) | | Feature | Code | SAMXON Produc | i |
| EKS | 0.1 | 104 | ±5 | 1 | 2.5 | 0D 0E | 3 | B 1 | Radial bulk | RR | For internal use (The product line | |
| EGS | 0.22 | 224 | ±10 | к | 4 6.3 | 0G 0J | <u> </u> | C D | Ammo Tap | ping | have H,A,B,C,D,E 0,1,2,3,4,5,9 | |
| EKG EOM | | | ±15 | L | 8 | 0K | 6.3 | E | 2.0mm Pitch | Π | | <u> </u> |
| EGF | 0.33 | 334 | ±20 | м | 10 | 1A | 8 | F | 2.01111110 | \vdash | Sleeve Material | Code |
| ESF | 0.47 | 474 | ±30 | N | 12.5 | 1B 1C | 12.5 13 | J | 2.5mm Pitch | TU | PET | Р |
| EGK ESK | 1 | 105 | -40 0 | w | 20 25 | 1D 1E | 13.5 14 | V 4 | 3.5mm Pitch | τv | | |
| ESH | | | | | 30 | 11 | 14.5 16 | A K | 5.0mm Pitch | тс | | |
| ESK ERS | 2.2 | 225 | -20 0 | A | 32 | 13 1V | 16.5 18 | / | Lead Cut & | Form | | |
| EGY | 3.3 | 335 | -20 | c | 40 | 1G | 18.5 20 | 8 M | Lead Cut a | | | |
| ERR | 4.7 | 475 | +10 | | 42 | 1M 1H | 22 25 | N O | CB-Type | CB | | |
| ERT | | | -20 +40 | x | 57 | 1L | 30 34 | P W | CE-Type | CE | | , |
| ERD ERH | 10 | 106 | -20 | | 63 | 1J 1S | 35 40 | Q R | HE-Type | HE | PVC | |
| EBD ERA | 22 | 226 | +50 | S | 75 | 1T | 42 45 | 4 | | кр | FV% | |
| ERB | 33 | 336 | -10 | в | 80 85 | 1K 1R | 51 63.5 | S T | KD-Type | | | |
| ERC | | | -10 | $\left - \right $ | 90 | 19 | 76 80 | U 8 | FD-Type | FD | | |
| ENP | 47 | 476 | +20 | v | 100 | 2A 20 | <u>90</u> 100 | X Z | EH-Type | EH | | |
| ERW | 100 | 107 | -10 | Q | 125 | 2B | Len. (mm) 4.5 | Code 45 | PCB Termi | inal | | |
| ERY | 220 | 227 | +30 | | 150 160 | 2Z 2C | 5 5.4 | 05 54 | | sw | | |
| EAP | 220 | 227 | -10 +50 | Т | 180 | 2P | 7 | 07 77 | | 500 | | ' , = |
| EDP | 330 | 337 | +13 | E | 200 | 2D 22 | 10.2 11 | T2 11 | Snap-in | SX | | |
| EHP | 470 | 477 | +50 | | 220 | 2N | 11.5 12 | 1A 12 | | sz | | |
| EUP EKP | 2200 | 228 | -5 +15 | F | 230 | 23 2E | 12.5 13 | 1B 13 | Lug | SG | | |
| EPK EEP | 2200 | 228 | -5 | G | 275 300 | 2T 2I | 13.5 20 | 1C 20 | | | | |
| EFP | 22000 | 229 | +20 | ° | 310 | 21 2R | 25 29.5 | 25 2J | | 05 | | |
| ESP EVP | 33000 | 339 | 0 +20 | R | 315 330 | 2F 2U | 30 31.5 | 30 3A | | 06 | | |
| EGP | 47000 | 479 | 0 | | 350 | 2V | 35 | 35 3E | | Т5 | | |
| EWI | 47000 | 4/9 | +30 | 0 | 360 375 | 2X 2Q | 50 | 50 80 | Screw | тө | | |
| EWX | 100000 | 10T | 0 | 1 | 385 | 2Y | 100 105 | 1L 1K | | | | |
| EWF EWH | 150000 | 15T | +5 | $\left - \right $ | 400 420 | 2G 2M | 110 120 | 1M 1N | | D5 | | |
| EWL EWB | 220000 | 227 | +15 | Z | 450 | 2W | 130 | 1P 1Q | | D6 | | |
| VS1 | 220000 | 22T | +5 +20 | D | 500 | 2H 25 | 150 | 10 1R 1E | | | | |
| VT1 VTD | 330000 | 33T | | $\left - \right $ | 600 | 26 | 160 | 15 1F | | | | |
| VTG VZ2 | 1000000 | 10M | +10 +50 | н | 630 | 2J | 170 | 1T 1U | | | | |
| VTL | 4500000 | 4544 | | | | | 190 | 10 1V 2L | | | | |
| | 1500000 | 15M | | | | | 215 | 2L 2A 2M | | | | |
| | 2200000 | 22M | | | | | 210 220 | 2N | | | | |
| | 3300000 | 33M | | | | | 240 250 | 2Q 2R | | | | |
| | | <u> </u> | | | | | 260 270 | 25 2T | | | | |
| | | | | | | | | | | | | |
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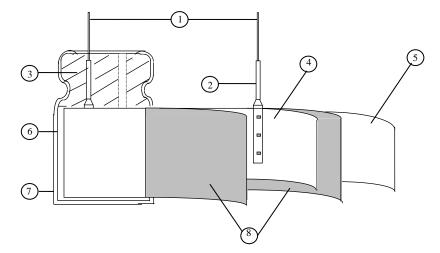
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3. Construction

Single ended type to be produced to fix the terminals to anode and cathode foil, and wind together with paper, and then wound element to be impregnated with electrolyte will be enclosed in an aluminum case. Finally sealed up tightly with end seal rubber, then finished by putting on the vinyl sleeve.



| No | Component | Material |
|----|------------------|--|
| 1 | Lead line | Tinned CP wire (Pb Free) |
| 2 | Terminal | Aluminum wire |
| 3 | Sealing Material | Rubber |
| 4 | Al-Foil (+) | Formed aluminum foil |
| 5 | Al-Foil (-) | Etched aluminum foil or formed aluminum foil |
| 6 | Case | Aluminum case |
| 7 | Sleeve | PET |
| 8 | Separator | Electrolyte paper |

4. Characteristics

Standard atmospheric conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurements and tests are as follows:

| Ambient temperature | :15°C to 35°C |
|---------------------|-------------------|
| Relative humidity | : 45% to 85% |
| Air Pressure | : 86kPa to 106kPa |

If there is any doubt about the results, measurement shall be made within the following conditions:

| Ambient temperature | $: 20^{\circ}C \pm 2^{\circ}C$ |
|---------------------|--------------------------------|
| Relative humidity | : 60% to 70% |
| Air Pressure | : 86kPa to 106kPa |

Operating temperature range

The ambient temperature range at which the capacitor can be operated continuously at rated voltage See table 1 temperature range.

As to the detailed information, please refer to table 2.

| T T 1 | 0.1 | D | ~ |
|--------------|-----|------|---|
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| | ITEM | | | | PERFC | RMANO | CE | | | |
|-----|---------------------------------------|---|--|---|--|---|-----------------------------|--|--|------------|
| | Rated voltage | | | | | | | | | |
| | (WV) | WV (V.DC) | 6.3 | 10 | 16 | 25 | 35 | 50 | 63 | 100 |
| 4.1 | | SV (V.DC) | 8 | 13 | 20 | 32 | 44 | 63 | 79 | 125 |
| | Surge voltage (SV) | | | | | | | | | . <u> </u> |
| 4.2 | Nominal capacitance (Tolerance) | Condition> Measuring F Measuring V Measuring T <criteria> Shall be with</criteria> | requency oltage 'emperat | : N ure : 20 |)±2℃ | han 0.5V | | | | |
| 4.3 | Leakage current | <condition></condition> Connecting the capacitor with a protective resistor $(1k\Omega \pm 10\Omega)$ in series for 2 minutes, and then, measure Leakage Current. <criteria></criteria> Refer to Table 1 | | | | | | | | |
| 4.4 | tanδ | <condition> See 4.2, Norr <criteria> Refer to Table</criteria></condition> | n Capac | itance, fo | or measu | ing frequ | iency, vo | oltage and | d tempera | ature. |
| 4.5 | Terminal strength | 0.5r Over 0. < Criteri | ength of capacitor rength of pacitor, $2 \sim 3$ seco er of lea nm and l 5mm to a > | , applied Termina applied f nds, and d wire ess 0.8mm | force to lls. force to b then ber Tens | ent the te t it for 9 ile force (kgf) $\overline{5} (0.51)$ $\overline{0} (1.0)$ | erminal (0° to its N | 1~4 mm ; original ; Bending (k 2.5 (5 (0 | from the position y force N gf) 0.25) 0.51) | rubber) fo |

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ELECTROLYTIC CAPACITOR SPECIFICATION GF SERIES

| | | <condi< th=""><th></th><th><i>·</i>: T</th><th>(°C)</th><th>. </th><th></th><th>T'</th><th></th><th></th></condi<> | | <i>·</i> : T | (°C) | . | | T ' | | |
|-----|-------------------------------|---|--|--|---|--|--|--|--|---|
| | | | | sting Tempe | | | · 1 | Time | .1.1 . | |
| | | | 1 | 20±2 | | | to reach | | | |
| | | | 2 | -40(-25) | | | to reach | | * | |
| | | | 3 | 20± | | | to reach | | - | |
| | | | 4 | $105 \pm$ | | | to reach | | * | |
| | | | 5 | 20± | 2 | Time | to reach | thermal of | equilibri | um |
| | | <criter< td=""><td></td><td></td><td></td><td></td><td></td><td></td><td></td><td></td></criter<> | | | | | | | | |
| | | | δ shall be w | | | 4.4The l | eakage ci | irrent me | easured s | shall not |
| | Temperature | | an 8 times c | - | | sit of Iton | n 4 4Tha | laalaaa | aurmont | chall not |
| | characteristi | | tep 5, tanδ s nan the speci | | min the mi | int of the | n 4.41 ne | leakage | current | snan not |
| 4.6 | cs | | 40°C (-25°C) | | e (z) ratio | shall not | exceed th | e value d | of the fo | llowing |
| | | table. | +0 C (-25 C) | , impedance | (\mathbf{Z}) ratio s | siiaii iiot | | | | nowing |
| | | | g Voltage (V | 6.3 | 10 | 16 | 25 | 35 | 50 | 63 |
| | | | °C/Z+20°C | 4 | 3 | 2 | 2 | 2 | 2 | 2 |
| | | | °C/Z+20°C | 8 | 6 | 4 | 3 | 3 | 3 | 3 |
| | | 210 | 0/2120 0 | Ű | | • | 3 | 3 | 5 | 5 |
| | | | g Voltage (V |) 100 | | | | | | |
| | | Z-25° | °C/Z+20°C | 2 | | | | | | |
| | | Z-40° | °C/Z+20°C | 3 | | | | | | |
| | | For capa | For capacitance value > 1000 μ F, Add 0.5 per another 1000 μ F for Z-25/Z+20°C | | | | | | | |
| | | | | | | - | | - | | |
| | | | | | |) per ano | ther 1000 | μ F for 2 | Z-40℃/2 | Z+20℃. |
| | | Capacita | ance, tano, a | and impeda | |) per ano | ther 1000 | μ F for 2 | Z-40°C/Z | Z+20℃. |
| | | Capacita | | and impeda | |) per ano | ther 1000 | μ F for 2 | Z-40°C/2 | Z+20℃. |
| | | <condi< td=""><td></td><td>-</td><td>nce shall b</td><td>) per ano e measur</td><td>ther 1000 red at 120</td><td>µ F for 2)Hz.</td><td></td><td></td></condi<> | | - | nce shall b |) per ano e measur | ther 1000 red at 120 | µ F for 2)Hz. | | |
| | | <condi Accordi</condi | ition> |)384-4No.4. | nce shall b |) per ano e measur | ther 1000 red at 120 apacitor is |)Hz. | at a temp | erature of |
| | | <condi Accordi 105 ℃ : DC and</condi | ition> ing to IEC60 ±2 with DC 1 ripple peal |)384-4No.4. bias voltage k voltage sl | nce shall b 13 method e plus the r hall not es |) per ano e measur ls, The ca rated ripp kceed the | ther 1000 red at 120 pacitor is le curren e rated w | by F for 2 DHz. s stored a t for Tab yorking y | at a temp ble 1. (T voltage) | erature of he sum of Then the |
| | | Condi Accordi 105 °C : DC and product | ition> ing to IEC60 ± 2 with DC d ripple peal t should be te |)384-4No.4. bias voltage k voltage sl ested after 10 | 13 method e plus the r hall not ex 6 hours red |) per ano e measur ls, The ca rated ripp kceed the | ther 1000 red at 120 pacitor is le curren e rated w | by F for 2 DHz. s stored a t for Tab yorking y | at a temp ble 1. (T voltage) | erature of he sum of Then the |
| | Load | Condi Accordi 105 °C : DC and product result sh | ition> ing to IEC60 ± 2 with DC d ripple peal t should be te hould meet t |)384-4No.4. bias voltage k voltage sl ested after 10 | 13 method e plus the r hall not ex 6 hours red |) per ano e measur ls, The ca rated ripp kceed the | ther 1000 red at 120 pacitor is le curren e rated w | by F for 2 DHz. s stored a t for Tab yorking y | at a temp ble 1. (T voltage) | erature of he sum of Then the |
| 4.7 | life | Condi Accordi 105 ℃ : DC and product result sh <criter< p=""></criter<> | ition> ing to IEC60 ± 2 with DC 1 ripple peal t should be te hould meet t ria > | 384-4No.4. bias voltage k voltage sl sted after 10 he following | 13 method 13 method e plus the r hall not es 6 hours red g table: |) per ano e measur ls, The ca rated ripp kceed the covering | ther 1000 red at 120 apacitor is le curren e rated w time at at | by F for 2 DHz. s stored a t for Tab yorking y | at a temp ble 1. (T voltage) | erature of he sum of Then the |
| 4.7 | | Condi Accordi 105 ℃ = DC and product result sh <criten The char</criten | ition> ing to IEC60 ± 2 with DC 1 ripple peal t should be te hould meet t ria> aracteristic s |)384-4No.4. bias voltage k voltage sl ested after 1 he following hall meet th | 13 method 13 method e plus the r hall not ex 6 hours red g table: e followin | ds, The ca rated ripp covering | ther 1000 red at 120 apacitor is le curren e rated w time at at ements. | μ F for 2 DHz. s stored a t for Tab vorking v mospher | at a temp ble 1. (T voltage) | erature of he sum of Then the |
| 4.7 | life | Condi Accordi 105 ℃ : DC and product result sh <criter The cha I</criter | ition> ing to IEC60 ± 2 with DC d ripple peal t should be te hould meet t ria> aracteristic s Leakage curr | 384-4No.4. bias voltage sl ested after 10 he following hall meet th rent | 13 method e plus the r hall not ex 6 hours red g table: te followin Value in | b per ano e measur ds, The ca rated ripp covering <u>g require</u> 4.3 shall | ther 1000 red at 120 apacitor is le curren e rated w time at at ements. be satisf | μ F for 2 DHz. s stored a t for Tab rorking v mospher | at a temp ble 1. (T voltage) | erature of he sum of Then the |
| 4.7 | life | $<$ CondiAccordi $105 \ C$ DC andproductresult sh $<$ CriterThe chaIC | ition> ing to IEC60 ± 2 with DC 1 ripple peal t should be te hould meet t ria> aracteristic s Leakage curr Capacitance | 384-4No.4. bias voltage sl ested after 10 he following hall meet th rent | 13 method e plus the r hall not ez 6 hours red g table: ne followin Value in Within ± | b per ano e measur ls, The ca rated ripp kceed the covering <u>g require</u> 4.3 shall <u>225% of</u> | ther 1000 red at 120 apacitor is le curren e rated w time at at ements. be satisf | μ F for 2 DHz. s stored a t for Tab vorking v mospher ied | at a temp ble 1. (T voltage) ic condit | erature of he sum of Then the tions. The |
| 4.7 | life | <CondiAccordi105 °C =DC andproductresult sh $<$ CriterThe chaICCICICICICICICICICICIICII | ition> ing to IEC60 ± 2 with DC 1 ripple peal t should be te hould meet t ria> aracteristic s Leakage curr Capacitance ranð | 384-4No.4. bias voltage sl ested after 10 he following hall meet th rent | 13 method e plus the r hall not ex 6 hours red g table: e followin Value in Within <u>-</u> | b per ano e measure ds, The car rated ripp acceed the covering <u>g require</u> 4.3 shall <u>25% of</u> e than 15 | ther 1000 red at 120 apacitor is le curren e rated w time at at ements. be satisf initial va 0% of the | μ F for 2 DHz. s stored a t for Tab gorking v mospher ied alue. e specifie | at a temp ble 1. (T voltage) ic condit | erature of he sum of Then the tions. The |
| 4.7 | life | <CondiAccordi105 °C =DC andproductresult sh $<$ CriterThe chaICCICICICICICICICICICIICII | ition> ing to IEC60 ± 2 with DC 1 ripple peal t should be te hould meet t ria> aracteristic s Leakage curr Capacitance | 384-4No.4. bias voltage sl ested after 10 he following hall meet th rent | 13 method e plus the r hall not ez 6 hours red g table: ne followin Value in Within ± | b per ano e measure ds, The car rated ripp acceed the covering <u>g require</u> 4.3 shall <u>25% of</u> e than 15 | ther 1000 red at 120 apacitor is le curren e rated w time at at ements. be satisf initial va 0% of the | μ F for 2 DHz. s stored a t for Tab gorking v mospher ied alue. e specifie | at a temp ble 1. (T voltage) ic condit | erature of he sum of Then the tions. The |
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| 4.7 | life | $<$ Condi $Accordi105 \ CDC andproductresult sh< CriterThe chaICt< Cond$ | ition> ing to IEC60 \pm 2 with DC 1 ripple peal t should be te hould meet t ria> aracteristic s Leakage curr Capacitance anð Appearance |)384-4No.4. bias voltage k voltage sl ested after 10 he followin; hall meet th rent Change | 13 method e plus the r hall not ex 6 hours red g table: e followin Value in Within = Not more There sha | b per ano e measure ls, The car rated ripp acceed the covering <u>e require</u> 4.3 shall <u>25% of</u> <u>e than 15</u> all be no | ther 1000 red at 120 apacitor is le curren e rated w time at at <u>ements.</u> <u>be satisfi</u> <u>initial va</u> <u>leakage o</u> | μ F for 2 http://www.stored.ac. s stored a t for Tab yorking v mospher ied alue. specifie of electro | at a temp ble 1. (T voltage) ic condit ed value. | erature of he sum of Then the tions. The |
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| 4.7 | life | Condi Accordi 105 $^{\circ}$ C DC and product result sh <criter< p=""> The cha I C C I Cond The capa 1000+4</criter<> | ition> ing to IEC60 \pm 2 with DC d ripple peal t should be te hould meet t ria> aracteristic s Leakage curr Capacitance can δ Appearance lition> acitors are th 8/0 hours. F | 0384-4No.4. bias voltage k voltage sl ested after 10 he following hall meet th rent Change en stored wi ollowing th | 13 method e plus the r hall not ex 6 hours red g table: e followin Value in Within d Not more There sha | b per ano e measur ls, The ca rated ripp cceed the covering <u>g require</u> 4.3 shall <u>25% of</u> e than 15 all be no | ther 1000 red at 120 apacitor is ale curren e rated w time at at <u>ements.</u> be satisfinitial va 0% of the leakage of ed at a te itors shal | μ F for 2 DHz. s stored a t for Tab rorking v mospher ied alue. specific of electro mperatur l be remo | at a temp ble 1. (T voltage) ic condit ed value. blyte. re of 105 oved from | erature of he sum of Then the ions. The $\pm 2^{\circ}C$ fo m the tes |
| 4.7 | life | <condi< th=""><math>Accordi$105 \ C$$DC$ andproductresult sh<criter< td="">The chaI(C)I(C)I(C)I(C)I(C)I(C)I(C)I(C)I(C)I(C)II(C)II(C)III<tr< math=""></tr<></criter<></math></condi<> | ition> ing to IEC60 \pm 2 with DC d ripple peal t should be te hould meet t ria> aracteristic s Leakage curr Capacitance anð Appearance | 0384-4No.4. bias voltage k voltage sl ested after 10 he following hall meet th rent Change en stored wi ollowing th owed to sta | 13 method e plus the p hall not end 6 hours red g table: ne followin Value in Within d Not more There sha ith no volta is period t bilized at | b per ano e measur ls, The ca rated ripp cceed the covering <u>g require</u> 4.3 shall <u>25% of</u> <u>e than 15</u> <u>all be no</u> age applic he capac room ter | ther 1000 red at 120 apacitor is ale curren e rated w time at at <u>be satisf</u> initial va <u>0% of the</u> leakage of ed at a te itors shal appendure | μ F for 2 http://www.stored.ac. s stored a t for Tab yorking w mospher ied alue. specifie of electron mperatur l be remove for 4~8 | at a temp ble 1. (T voltage) ic condit ed value. blyte. re of 105 oved from hours. 1 | erature of he sum of Then the tions. The $\pm 2^{\circ}C$ for m the tes Next they |
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| | life test Shelf life | $<$ Condi $105 \ C$ DC and $product$ result sh $<$ CriterThe chaIII <td< td=""><td>ition> ing to IEC60 \pm2 with DC d ripple peal t should be te hould meet t ria> aracteristic s Leakage curr Capacitance anð Appearance lition> actiors are th t8/0 hours. F er and be all e connected for 30min. A</td><td>0384-4No.4. bias voltage k voltage sl ested after 10 he following hall meet th rent Change en stored wi ollowing th owed to sta to a series</td><td>13 method e plus the r hall not ex 6 hours red g table: e followin Value in Within <u>d</u> Not more There sha ith no volta is period t bilized at limiting re</td><td>b per ano e measur ls, The ca rated ripp kceed the covering <u>eg require</u> 4.3 shall <u>25% of</u> <u>e than 15</u> all be no age applic he capac room ter esistor(11</td><td>ther 1000 red at 120 apacitor is ale curren e rated w time at at ments. be satisficient be satisficient be satisficient be satisficient antial va 0% of the leakage of ed at a te itors shal apperature $x \pm 100\Omega$</td><td>μ F for 2 DHz. s stored a t for Tab yorking w mospher ied alue. specifie of electro f electro l be rema for 4~8) with Γ</td><td>at a temp ble 1. (T. voltage) ic condit ed value. ad value. ad value. ad value. blyte. re of 105 poved from hours. 1 D.C. rate</td><td>erature of he sum of Then the tions. The $\pm 2^{\circ}C$ fo m the tes Next they d voltage</td></td<> | ition> ing to IEC60 \pm 2 with DC d ripple peal t should be te hould meet t ria> aracteristic s Leakage curr Capacitance anð Appearance lition> actiors are th t8/0 hours. F er and be all e connected for 30min. A | 0384-4No.4. bias voltage k voltage sl ested after 10 he following hall meet th rent Change en stored wi ollowing th owed to sta to a series | 13 method e plus the r hall not ex 6 hours red g table: e followin Value in Within <u>d</u> Not more There sha ith no volta is period t bilized at limiting re | b per ano e measur ls, The ca rated ripp kceed the covering <u>eg require</u> 4.3 shall <u>25% of</u> <u>e than 15</u> all be no age applic he capac room ter esistor(11 | ther 1000 red at 120 apacitor is ale curren e rated w time at at ments. be satisficient be satisficient be satisficient be satisficient antial va 0% of the leakage of ed at a te itors shal apperature $x \pm 100\Omega$ | μ F for 2 DHz. s stored a t for Tab yorking w mospher ied alue. specifie of electro f electro l be rema for 4~8) with Γ | at a temp ble 1. (T. voltage) ic condit ed value. ad value. ad value. ad value. blyte. re of 105 poved from hours. 1 D.C. rate | erature of he sum of Then the tions. The $\pm 2^{\circ}C$ fo m the tes Next they d voltage |
| | life test Shelf life | $<$ Condi $105 \ C$ DC and $product$ result sh $<$ CriterThe chaIII <td< td=""><td>ition> ing to IEC60 \pm2 with DC d ripple peal t should be te hould meet t ria> aracteristic s Leakage curr Capacitance anð Appearance lition> actiors are th t8/0 hours. F er and be all e connected for 30min. A</td><td>0384-4No.4. bias voltage k voltage sl ested after 10 he following hall meet th rent Change en stored wi ollowing th owed to sta to a series</td><td>13 method e plus the r hall not ex 6 hours red g table: e followin Value in Within <u>d</u> Not more There sha ith no volta is period t bilized at limiting re</td><td>b per ano e measur ls, The ca rated ripp kceed the covering <u>eg require</u> 4.3 shall <u>25% of</u> <u>e than 15</u> all be no age applic he capac room ter esistor(11</td><td>ther 1000 red at 120 apacitor is ale curren e rated w time at at ments. be satisficient be satisficient be satisficient be satisficient antial va 0% of the leakage of ed at a te itors shal apperature $x \pm 100\Omega$</td><td>μ F for 2 DHz. s stored a t for Tab yorking w mospher ied alue. specifie of electro f electro l be rema for 4~8) with Γ</td><td>at a temp ble 1. (T. voltage) ic condit ed value. ad value. ad value. ad value. blyte. re of 105 poved from hours. 1 D.C. rate</td><td>erature of he sum of Then the tions. The $\pm 2^{\circ}C$ fo m the tes Next they d voltage</td></td<> | ition> ing to IEC60 \pm 2 with DC d ripple peal t should be te hould meet t ria> aracteristic s Leakage curr Capacitance anð Appearance lition> actiors are th t8/0 hours. F er and be all e connected for 30min. A | 0384-4No.4. bias voltage k voltage sl ested after 10 he following hall meet th rent Change en stored wi ollowing th owed to sta to a series | 13 method e plus the r hall not ex 6 hours red g table: e followin Value in Within <u>d</u> Not more There sha ith no volta is period t bilized at limiting re | b per ano e measur ls, The ca rated ripp kceed the covering <u>eg require</u> 4.3 shall <u>25% of</u> <u>e than 15</u> all be no age applic he capac room ter esistor(11 | ther 1000 red at 120 apacitor is ale curren e rated w time at at ments. be satisficient be satisficient be satisficient be satisficient antial va 0% of the leakage of ed at a te itors shal apperature $x \pm 100\Omega$ | μ F for 2 DHz. s stored a t for Tab yorking w mospher ied alue. specifie of electro f electro l be rema for 4~8) with Γ | at a temp ble 1. (T. voltage) ic condit ed value. ad value. ad value. ad value. blyte. re of 105 poved from hours. 1 D.C. rate | erature of he sum of Then the tions. The $\pm 2^{\circ}C$ fo m the tes Next they d voltage |

| | | <criteria></criteria> | |
|------|-------------------|--|---|
| | | The characteristic shall meet | |
| | C1 1C | Leakage current | Value in 4.3 shall be satisfied |
| 4.8 | Shelf life | Capacitance Change | Within $\pm 25\%$ of initial value. |
| 4.0 | test | tanδ | Not more than 150% of the specified value. |
| | test | Appearance | There shall be no leakage of electrolyte. |
| | | Remark: If the capacitors are | stored more than 1 year, the leakage current may |
| | | increase. Please apply voltage | e through about 1 k Ω resistor, if necessary. |
| 4.9 | Surge test | The capacitor shall be submit followed discharge of 5 min The test temperature shall b C_R :Nominal Capacitance (μ <criteria></criteria> Leakage current Capacitance Change tan δ Appearance Attention: | e 15~35°C. I F) Not more than the specified value. Within ±15% of initial value. Not more than the specified value. There shall be no leakage of electrolyte. ge at abnormal situation only. It is not applicable to such |
| 4.10 | Vibration test | perpendicular directions. Vibration frequency ra Peak to peak amplitude Sweep rate Mounting method: The capacitor with diameter g in place with a bracket. 4mm or less 4mm or less Criteria > After the test, the following in Inner construction | e : 1.5mm : 10Hz ~ 55Hz ~ 10Hz in about 1 minute greater than 12.5mm or longer than 25mm must be fixed Within 30° |

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ELECTROLYTIC CAPACITOR SPECIFICATION GF SERIES



| 4.11Solderability testCondition> The capacitor shall be tested under the following conditions: Sn-Cu solder Soldering temperature $: 250\pm 3^{\circ}\mathbb{C}$ Dipping depth $: 2mm$ Dipping time $: 3\pm 0.5s$ Criteria>4.11Solderability testCoating qualityA minimum of 95% of the surface being immersed I_{12} Resistance to solder heat test Coating qualityA minimum of 95% of the surface being immersed4.12Resistance to solder heat test Condition> Terminals of the capacitor shall be intersed into solder bath at $260\pm 5^{\circ}\mathbb{C}$ for 10: 1 seconds to $1.5-2.0mm$ from the body of capacitor . Then the capacitor shall be left under the normal temperature and normal humidity for $1-2$ hours before measurement.4.12Resistance to solder heat testNot more than the specified value. Capacitance Change Within $\pm 10\%$ of initial value. The shall be no leakage of electrolyte.4.13Change of temperature test (1)+20^{\circ}\mathbb{C} (2)Rated low temperature ($40^{\circ}\mathbb{C}$) ($25^{\circ}\mathbb{C}$) 30 ± 2 Minutes (1)+20^{\circ}\mathbb{C} (2)Rated low temperature ($40^{\circ}\mathbb{C}$) ($25^{\circ}\mathbb{C}$) 30 ± 2 Minutes (1)+20^{\circ}\mathbb{C} (1) to (3)=1 cycle, total 5 cycle (1) to (3)=1 cycle, total 5 cycle (1) to (3)=1 cycle, total 5 cycle4.13Change of temperature testNot more than the specified value. Time (1)+20^{\circ}\mathbb{C} (2)Rated low temperature ($40^{\circ}\mathbb{C}$) ($25^{\circ}\mathbb{C}$) 30 ± 2 Minutes (1) to (3)=1 cycle, total 5 cycle (1) to (3 | | | | | |
|---|------|-------------|---|--|--|
| 4.12 Condition> Terminals of the capacitor shall be immersed into solder bath at $260 \pm 5^{\circ}$ Cfor10: Iseconds or $400 \pm 10^{\circ}$ Cfor3 ⁺¹ / ₋₀ seconds to $1.5 - 2.0$ mm from the body of capacitor . Then the capacitor shall be left under the normal temperature and normal humidity for $1 - 2$ hours before measurement. 4.12 Resistance to solder heat test Leakage current Not more than the specified value. Capacitance Change Within $\pm 10\%$ of initial value. Appearance Leakage or remeasurement. Condition> Condition> Temperature Cycle: According to IEC60384-4No.4.7methods, capacitor shall be placed in an oven, the condition according as below: Change of temperature test Temperature (-40°C) (-25°C) 30 ± 2 Minutes (1)+20°C (2)Rated low temperature (+105°C) 30 ± 2 Minutes (1) to (3)=1 cycle, total 5 cycle (1) to (3)=1 cycle, total 5 cycle Criteria> The characteristic shall meet the following requirement Leakage current Not more than the specified value. Appearance Not more than the specified value. Appearance There shall be no leakage of electrolyte. Condition> The characteristic shall meet the following requirement Leakage of electrolyte. Condition> Humidity Test: According to IEC60384-4No.4.12 methods, capacitor shall be exposed for 500 ± 8 hours in an atmosphere of 90~95% R H. at 40 ± 2°C, the characteristic change shall | 4.11 | - | The capacitor shall be test Soldering temperature Dipping depth Dipping speed Dipping time < Criteria > | : 250±3°C : 2mm : 25±2.5mm : 3±0.5s | ı/s |
| 4.12Terminals of the capacitor shall be immersed into solder bath at $260 \pm 5^{\circ}$ Cfor10: 1 seconds or $400 \pm 10^{\circ}$ Cfor3 $_{-1}^{+0}$ seconds to $1.5-2.0$ mm from the body of capacitor . Then the capacitor shall be left under the normal temperature and normal humidity for 1-2 hours before measurement. Criteria> 4.12Resistance to solder heat testLeakage currentNot more than the specified value. Capacitance Change Within $\pm 10\%$ of initial value. Appearance4.13Change of temperature test Condition> Temperature Cycle: According to IEC60384-4No.4.7methods, capacitor shall be placed in an oven, the condition according as below: Temperature ($(1)+20^{\circ}$ C ((2) Rated low temperature (-40° C) (-25° C) 30 ± 2 Minutes ((1) teored high temperature (-40° C) (-25° C) 30 ± 2 Minutes ((1) to $(3)=1$ cycle, total 5 cycle Criteria> The characteristic shall meet the following requirementLeakage currentNot more than the specified value. 1 tan $\overline{\delta}$ Not more than the specified value. 1 tan $\overline{\delta}$ Not more than the specified value. 1 to $(2)=1$ cycle, total 5 cycle Criteria> The characteristic shall meet the following requirementLeakage currentNot more than the specified value. 1 tan $\overline{\delta}$ Not more than the specified value. 1 tan $\overline{\delta}$ Not more than the specified value. Appearance There shall be no leakage of electrolyte. Condition> The characteristic shall meet the following requirementLeakage currentNot more than the specified value. 1 tan $\overline{\delta}$ Not more than the specified value. Appearance There shall be no leakage of electrolyte. Condition> Humidity Test: According to IEC60384-4No.4.12 methods, | | | Coaring quanty | immersed | |
| 4.13Change of temperature testTemperature Cycle:According to IEC60384-4No.4.7methods, capacitor shall be placed in an oven, the condition according as below: | 4.12 | solder heat | Terminals of the capacitor 1 seconds or $400 \pm 10^{\circ}$ C for Then the capacitor shall b for 1~2 hours before mean <criteria></criteria> Leakage current Capacitance Change tan δ | $r3_{-0}^{+1} \text{ seconds to } 1.5 \sim 2.0$ The left under the normal surement. Not more than to the | Imm from the body of capacitor . temperature and normal humidity he specified value. of initial value. he specified value. |
| <condition> Humidity Test: According to IEC60384-4No.4.12 methods, capacitor shall be exposed for 500 ± 8 hours in an atmosphere of $90\sim95\%$ R H .at 40 ± 2°C, the characteristic change shall</condition> | 4.13 | temperature | Temperature Cycle:Accon placed in an oven, the cor Te $(1)+20^{\circ}C$ (2)Rated low tempera $(3)Rated high tempera(1) to (3)=1 cycle, torThe characteristic shall mLeakage currenttan\delta$ | ndition according as below emperature ature (-40 $^{\circ}$ C) (-25 $^{\circ}$ C) rature (+105 $^{\circ}$ C) tal 5 cycle weet the following require Not more than the solution of the solution | Time \leq 3 Minutes 30 ± 2 Minutes 30 ± 2 Minutes 30 ± 2 Minutes gecified value. Specified value. |
| 4.14Damp heat test <criteria>4.14Damp heat testLeakage currentNot more than the specified value. Capacitance Change120% of initial value.120% of the specified value.1</criteria> | 4.14 | - | <condition> Humidity Test: According to IEC60384-4 hours in an atmosphere of meet the following require <criteria> Leakage current Capacitance Change tanδ</criteria></condition> | 4No.4.12 methods, capa f 90~95% R H .at 40 ± 2 ement. Not more than the spe Within $\pm 20\%$ of init Not more than 120% of | citor shall be exposed for 500 ± 8 °C, the characteristic change shall cified value. |

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ELECTROLYTIC CAPACITOR SPECIFICATION GF SERIES



| 4.15 | Vent test | 22.4 or lessOver 22.41 <criteria>The vent shall operate with no pieces of the capacitor and/or c</criteria> | th its polar ble is appli rent (A) 1 0 dangerous | ity reversed ed. | to a DC po | ower source | e. Then a |
|------|---|--|---|-----------------------------|-------------|-------------|-----------|
| 4.16 | Maximum permissible (ripple current) | <condition> The maximum permissible rip at 120Hz and can be applied Table-1 The combined value of D.C rated voltage and shall not re Frequency Multipliers: Coefficient Freq. (Hz) Cap. (µ F) ~180 220~560 680~1800 2200~3900 4700</condition> | at maximu voltage and | m operating I the peak A | g temperatu | re | sceed the |
| | | | | | | | |

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5. It refers to the latest document of "Environment-related Substances standard" (WI-HSPM-QA-072).

| | Substances |
|-----------------------|--|
| | Cadmium and cadmium compounds |
| Heavy metals | Lead and lead compounds |
| Treavy metals | Mercury and mercury compounds |
| | Hexavalent chromium compounds |
| | Polychlorinated biphenyls (PCB) |
| Chloinated | Polychlorinated naphthalenes (PCN) |
| organic | Polychlorinated terphenyls (PCT) |
| compounds | Short-chain chlorinated paraffins(SCCP) |
| | Other chlorinated organic compounds |
| D | Polybrominated biphenyls (PBB) |
| Brominated organic | Polybrominated diphenylethers(PBDE) (including |
| | decabromodiphenyl ether[DecaBDE]) |
| compounds | Other brominated organic compounds |
| Tributyltin comp | oounds(TBT) |
| Triphenyltin con | npounds(TPT) |
| Asbestos | |
| Specific azo com | pounds |
| Formaldehyde | |
| Beryllium oxide | |
| Beryllium copp | er |
| Specific phthalat | tes (DEHP,DBP,BBP,DINP,DIDP,DNOP,DNHP) |
| Hydrofluorocarb | on (HFC), Perfluorocarbon (PFC) |
| Perfluorooctane | sulfonates (PFOS) |
| Specific Benzotr | iazole |

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SAMXON

Attachment: Application Guidelines

1.Circuit Design

- 1.1 Operating Temperature and Frequency Electrolytic capacitor electrical parameters are normally specified at 20°C temperature and 120Hz frequency. These parameters vary with changes in temperature and frequency. Circuit designers should take these changes into consideration.
- (1) Effects of operating temperature on electrical parameters

 At higher temperatures, leakage current and capacitance increase while equivalent series resistance (ESR) decreases.
 - b) At lower temperatures, leakage current and capacitance decrease while equivalent series resistance (ESR) increases.
- (2) Effects of frequency on electrical parameters
 - a) At higher frequencies capacitance and impedance decrease while $\tan \delta$ increases.
 - b) At lower frequencies, ripple current generated heat will rise due to an increase in equivalent series resistance (ESR).
- 1.2 Operating Temperature and Life Expectancy See the file: Life calculation of aluminum electrolytic capacitor
- 1.3 Common Application Conditions to Avoid

The following misapplication load conditions will cause rapid deterioration to capacitor electrical parameters. In addition, rapid heating and gas generation within the capacitor can occur causing the pressure relief vent to operate and resultant leakage of electrolyte. Under Leaking electrolyte is combustible and electrically conductive.

(1) Reverse Voltage

DC capacitors have polarity. Verify correct polarity before insertion. For circuits with changing or uncertain polarity, use DC bipolar capacitors. DC bipolar capacitors are not suitable for use in AC circuits.

(2) Charge / Discharge Applications

Standard capacitors are not suitable for use in repeating charge / discharge applications. For charge / discharge applications consult us and advise actual conditions.

(3) Over voltage

Do not apply voltages exceeding the maximum specified rated voltage. Voltages up to the surge voltage rating are acceptable for short periods of time. Ensure that the sum of the DC voltage and the superimposed AC ripple voltage does not exceed the rated voltage.

(4) Ripple Current

Do not apply ripple currents exceeding the maximum specified value. For high ripple current applications, use a capacitor designed for high ripple currents or contact us with your requirements. Ensure that allowable ripple currents superimposed on low DC bias voltages do not cause reverse voltage conditions.

- 1.4 Using Two or More Capacitors in Series or Parallel
- (1) Capacitors Connected in Parallel

The circuit resistance can closely approximate the series resistance of the capacitor causing an imbalance of ripple current loads within the capacitors. Careful design of wiring methods can minimize the possibility of excessive ripple currents applied to a capacitor.

(2) Capacitors Connected in Series

Normal DC leakage current differences among capacitors can cause voltage imbalances. The use of voltage divider shunt resistors with consideration to leakage current can prevent capacitor voltage imbalances.

- 1.5 Capacitor Mounting Considerations
- (1) Double Sided Circuit Boards

Avoid wiring pattern runs, which pass between the mounted capacitor and the circuit board.

When dipping into a solder bath, excess solder may collect under the capacitor by capillary action and short circuit the anode and cathode terminals.

(2)Circuit Board Hole Positioning

The vinyl sleeve of the capacitor can be damaged if solder passes through a lead hole for subsequently processed parts. Special care when locating hole positions in proximity to capacitors is recommended.

(3)Circuit Board Hole Spacing

The circuit board holes spacing should match the capacitor lead wire spacing within the specified tolerances. Incorrect spacing can cause excessive lead wire stress during the insertion process. This may result in premature capacitor failure due to short or open circuit, increased leakage current, or electrolyte leakage.

(4) Clearance for Case Mounted Pressure Relief vents

Capacitors with case mounted pressure relief vents require sufficient clearance to allow for proper vent operation. The minimum clearances are dependent on capacitor diameters as proper vent operation. The minimum clearances are dependent on capacitor diameters as follows.

φ6.3~φ16mm:2mm minimum, φ18~φ35mm:3mm minimum, φ40mm or greater:5mm minimum.

(5) Clearance for Seal Mounted Pressure Relief Vents

A hole in the circuit board directly under the seal vent location is required to allow proper release of pressure.

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| (6) Wiring Near the Pressure Relief Vent Avoid locating high voltage or high current wiring or circuit board paths above the pressure relief vent. Flammable, high temperature gas exceeding 100°C may be released which could dissolve the wire insulation and ignite. (7) Circuit Board patterns Under the Capacitor Avoid circuit board runs under the capacitor as electrolyte leakage could cause an electrical short. (8) Screw Terminal Capacitor Mounting Do not orient the capacitor with the screw terminal side of the capacitor facing downwards. Tighten the terminal and mounting bracket screws within the torque range specified in the specification. |
| Electrical Isolation of the Capacitor Completely isolate the capacitor as follows. Between the cathode and the case (except for axially leaded B types) and between the anode terminal and other circuit paths Between the extra mounting terminals (on T types) and the anode terminal, cathode terminal, and other circuit paths. |
| 1.7 The Product endurance should take the sample as the standard. |
| 1.8 If conduct the load or shelf life test, must be collect date code within 6 months products of sampling. |
| Capacitor Sleeve The vinyl sleeve or laminate coating is intended for marking and identification purposes and is not meant to electrically insulate the capacitor. The sleeve may split or crack if immersed into solvents such as toluene or xylene, and then exposed to high temperatures. |
| CAUTION! |
| Always consider safety when designing equipment and circuits. Plan for worst case failure modes such as short circuits and open circuits which could occur during use. (1) Provide protection circuits and protection devices to allow safe failure modes. (2) Design redundant or secondary circuits where possible to assure continued operation in case of main circuit failure. |
| 2.Capacitor Handling Techniques |
| Considerations Before Using Capacitors have a finite life. Do not reuse or recycle capacitors from used equipment. Transient recovery voltage may be generated in the capacitor due to dielectric absorption. If required, this voltage can be discharged with a resistor with a value of about 1kΩ. Capacitors stored for long periods of time may exhibit an increase in leakage current. This can be corrected by gradually applying rated voltage in series with a resistor of approximately 1kΩ. If capacitors are dropped, they can be damaged mechanically or electrically. Avoid using dropped capacitors. Dented or crushed capacitors should not be used. The seal integrity can be compromised and loss of electrolyte / shortened life can result. |
| 2.2 Capacitor Insertion (1) Verify the correct capacitance and rated voltage of the capacitor. (2) Verify the correct polarity of the capacitor before inserting. (3) Verify the correct hole spacing before insertion (land pattern size on chip type) to avoid stress on the terminals. (4) Ensure that the auto insertion equipment lead clinching operation does not stress the capacitor leads where they enter the seal of the capacitor. For chip type capacitors, excessive mounting pressure can cause high leakage current, short circuit, or disconnection. |
| 2.3 Manual Soldering (1) Observe temperature and time soldering specifications or do not exceed temperatures of 400 °C for 3 seconds or less. (2) If lead wires must be formed to meet terminal board hole spacing, avoid stress on the lead wire where it enters the capacitor seal. (3) If a soldered capacitor must be removed and reinserted, avoid excessive stress to the capacitor leads. (4) Avoid touching the tip of the soldering iron to the capacitor, to prevent melting of the vinyl sleeve. |

- 2.4 Flow Soldering
- (1) Do not immerse the capacitor body into the solder bath as excessive internal pressure could result.
- (2) Observe proper soldering conditions (temperature, time, etc.) Do not exceed the specified limits.
- (3) Do not allow other parts or components to touch the capacitor during soldering.
- 2.5 Other Soldering Considerations

Rapid temperature rises during the preheat operation and resin bonding operation can cause cracking of the capacitor vinyl sleeve. For heat curing, do not exceed 150°C for a maximum time of 2 minutes.

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2.6 Capacitor Handling after Solder

- (1). Avoid movement of the capacitor after soldering to prevent excessive stress on the lead wires where they enter the seal.
- (2). Do not use capacitor as a handle when moving the circuit board assembly.
- (3). Avoid striking the capacitor after assembly to prevent failure due to excessive shock.
- 2.7 Circuit Board Cleaning

Acetone

- (1) Circuit boards can be immersed or ultrasonically cleaned using suitable cleaning solvents for up 5 minutes and up to 60°C maximum temperatures. The boards should be thoroughly rinsed and dried. The use of ozone depleting cleaning agents is not recommended in the interest of protecting the environment.
- (2) Avoid using the following solvent groups unless specifically allowed for in the specification;

Halogenated cleaning solvents: except for solvent resistant capacitor types, halogenated solvents can permeate the seal and cause internal capacitor corrosion and failure. For solvent resistant capacitors, carefully follow the temperature and time requirements of the specification. 1-1-1 trichloroethane should never be used on any aluminum electrolytic capacitor.

- Alkali solvents : could attack and dissolve the aluminum case.
- Petroleum based solvents: deterioration of the rubber seal could result.
- Xylene : deterioration of the rubber seal could result.
 - : removal of the ink markings on the vinyl sleeve could result.
- (3) A thorough drying after cleaning is required to remove residual cleaning solvents which may be trapped between the capacitor and the circuit board. Avoid drying temperatures, which exceed the maximum rated temperature of the capacitor.
- (4) Monitor the contamination levels of the cleaning solvents during use by electrical conductivity, pH, specific gravity, or water content. Chlorine levels can rise with contamination and adversely affect the performance of the capacitor. Please consult us for additional information about acceptable cleaning solvents or cleaning methods.

2.8 Mounting Adhesives and Coating Agents

When using mounting adhesives or coating agents to control humidity, avoid using materials containing halogenated solvents. Also, avoid the use of chloroprene based polymers. After applying adhesives or coatings, dry thoroughly to prevent residual solvents from being trapped between the capacitor and the circuit board.

3. Precautions for using capacitors

3.1 Environmental Conditions

- Capacitors should not be stored or used in the following environments.
- (1) Temperature exposure above the maximum rated or below the minimum rated temperature of the capacitor.
- (2) Direct contact with water, salt water, or oil.
- (3) High humidity conditions where water could condense on the capacitor.
- (4) Exposure to toxic gases such as hydrogen sulfide, sulfuric acid, nitric acid chlorine, or ammonia.
- (5) Exposure to ozone, radiation, or ultraviolet rays.
- (6) Vibration and shock conditions exceeding specified requirements.

3.2 Electrical Precautions

- (1) Avoid touching the terminals of the capacitor as possible electric shock could result. The exposed aluminum case is not insulated and could also cause electric shock if touched.
- (2) Avoid short circuit the area between the capacitor terminals with conductive materials including liquids such as acids or alkaline solutions.

4. Emergency Procedures

- (1) If the pressure relief vent of the capacitor operates, immediately turn off the equipment and disconnect form the power source. This will minimize additional damage caused by the vaporizing electrolyte.
- (2) Avoid contact with the escaping electrolyte gas which can exceed 100°C temperatures.

If electrolyte or gas enters the eye, immediately flush the eyes with large amounts of water.

If electrolyte or gas is ingested by month, gargle with water.

If electrolyte contacts the skin, wash with soap and water.

5. Long Term Storage

Leakage current of a capacitor increases with long storage times. The aluminum oxide film deteriorates as a function of temperature and time. If used without reconditioning, an abnormally high current will be required to restore the oxide film. This current surge could cause the circuit or the capacitor to fail. After one year, a capacitor should be reconditioned by applying rated voltage in series with a 1000Ω , current limiting resistor for a time period of 30 minutes. If the expired date of products date code is over eighteen months, the products should be return to confirmation.

5.1 Environmental Conditions

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The capacitor shall be not use in the following condition:

(1) Temperature exposure above the maximum rated or below the minimum rated temperature of the capacitor.

(2) Direct contact with water, salt water, or oil.

(3) High humidity conditions where water could condense on the capacitor.

(4) Exposure to toxic gases such as hydrogen sulfide, sulfuric acid, nitric acid, chlorine, or ammonia.

(5) Exposure to ozone, radiation, or ultraviolet rays.

(6) Vibration and shock conditions exceeding specified requirements.

6. Capacitor Disposal

When disposing of capacitors, use one of the following methods.

Incinerate after crushing the capacitor or puncturing the can wall (to prevent explosion due to internal pressure rise). Capacitors should be incinerated at high temperatures to prevent the release of toxic gases such as chlorine from the

polyvinyl chloride sleeve, etc.

Dispose of as solid waste.

NOTE: Local laws may have specific disposal requirements, which must be followed.

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